Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/665,482	YOSHIKAWA ET AL.	
Examiner	Art Unit	
David Dunn	3616	

SEARCHED				
Class	Subclass	Oate	Examiner	
280	729 730.1 730.2 752	9/1/2005	DD	
280	345.1	2 15 06	D	
	743.2			
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